

Notice of References Cited	Application/Control No. 10/814,273		Applicant(s)/Patent Under Reexamination MATSUSHI, TAKAYA	
	Examiner MATTHEW J. LUDWIG		Art Unit 2178	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,012,098 A	01-2000	Bayeh et al.	709/246
	B	US-			
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NON-PATENT DOCUMENTS

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